

**Search Notes****Application/Control No.**

10/626,140

**Examiner**

ALEX LIEW

**Applicant(s)/Patent under  
Reexamination**

FUKAGAWA ET AL.

**Art Unit**

2624

**SEARCHED**

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|   | DATE       | EXMR |
|---|------------|------|
| 382/141-152 (limited to text search)            | 10/12/2006 | AL   |
| 382/141-152 (limited to text search)<br>UPDATED | 1/23/2007  | AL   |
| 382/141-152 (limited to text search)            | 7/12/2007  | AL   |
| 382/141-152 (limited to text search)            | 12/21/2007 | AL   |
| 382/141-152 (limited to text search)            | 7/25/2008  | AL   |
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